3.3 V USB 3.1 Dual Channel Re-driver

Description

The NB7NPQ702M is a 3.3 V dual channel re-driver for USB 3.1 Gen 1 and USB 3.1 Gen 2 applications that supports both 5 Gbps and 10 Gbps data rates. Signal integrity degrades from PCB traces, transmission cables, and inter-symbol interference (ISI). The NB7NPQ702M compensates for these losses by engaging varying levels of equalization at the input receiver. The output transmitter circuitry provides user selectable de-emphasis settings to create the best eye openings for the outgoing data signals.

The NB7NPQ702M features an intelligent LFPS circuit. This senses the low frequency signals and automatically disables driver de–emphasis to meet full USB 3.1 Gen 1 and USB 3.1 Gen 2 compliances.

After power up, the NB7NPQ702M periodically checks both of the TX output pairs for a receiver connection. When the receiver is detected the RX termination becomes enabled and the NB7NPQ702M is set to perform the re-driver function.

The NB7NPQ702M comes in a small 3 x 3 mm UQFN16 package and is specified to operate across the entire industrial temperature range, -40° C to 85°C.

Features

- $3.3 \text{ V} \pm 5\%$ Power Supply
- Device Supports USB 3.1 Gen 1 and USB 3.1 Gen 2 Data Rates
- Automatic LFPS De-Emphasis Control
- Automatic Receiver Termination Detection
- Integrated Input and Output Termination
- Selectable Equalization and De-Emphasis
- Hot–Plug Capable
- ESD Protection ±4 kV HBM
- Operating Temperature Range: -40°C to 85°C
- Small 3 x 3 x 0.5 mm UQFN16 Package
- This is a Pb–Free Device

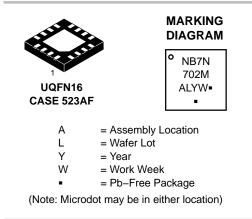
Typical Applications

- USB3.1 Type-C Signal Routing
- Mobile Phone and Tablet
- Computer and Laptop
- Docking Station and Dongle
- Active Cable, Back Planes
- Gaming Console, Smart T.V.



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ORDERING INFORMATION

| Device | Package | Shipping [†] |
|-----------------|---------------------|-----------------------|
| NB7NPQ702MMUTXG | UQFN16 (Pb–Free) | 3000 / Tape & Reel |

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

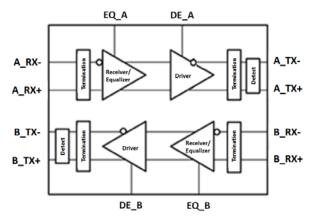
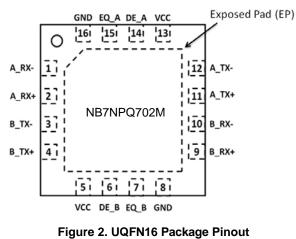


Figure 1. Logic Diagram of NB7NPQ702M



(Top View)

Table 1. PIN DESCRIPTION

| Pin Number | Pin Name | Туре | Description |
|---------------|----------|-----------|---|
| 1 | A_RX- | DIFF IN | Channel A Differential input pair for 5 / 10 Gbps USB signals. Must be externally AC-coupled. |
| 2 | A_RX+ | | |
| 3 | B_TX- | DIFF OUT | Channel B Differential output for 5 / 10 Gbps USB signals. Must be externally AC-coupled. |
| 4 | B_TX+ | | |
| 5 | VCC | Power | 3.3–V power supply. VCC pins must be externally connected to power supply to guarantee proper operation. |
| 6 | DE_B | LVCMOS IN | Sets the output de–emphasis gain on Channel B. 3–state input with integrated 250 k Ω pull–up and pull–down resistors. |
| 7 | EQ_B | LVCMOS IN | Sets the receiver equalizer gain on Channel B. 3–state input with integrated 250 k Ω pull–up and pull–down resistors. |
| 8 | GND | GND | Reference Ground. GND pins must be externally connected to power supply to guarantee proper operation. |
| 9 | B_RX+ | DIFF IN | Channel B Differential input pair for 5 / 10 Gbps USB signals. Must be externally AC-coupled. |
| 10 | B_RX- | | |
| 11 | A_TX+ | DIFF OUT | Channel A Differential output for 5 / 10 Gbps USB signals. Must be externally AC-coupled. |
| 12 | A_TX- | | |
| 13 | VCC | Power | 3.3–V power supply. VCC pins must be externally connected to power supply to guarantee proper operation. |
| 14 | DE_A | LVCMOS IN | Sets the output de–emphasis gain on Channel A. 3–state input with integrated 250 k Ω pull–up and pull–down resistors. |
| 15 | EQ_A | LVCMOS IN | Sets the receiver equalizer gain on Channel A. 3–state input with integrated 250 k Ω pull–up and pull–down resistors. |
| 16 | GND | GND | Reference Ground. GND pins must be externally connected to power supply to guarantee proper operation. |
| EP | GND | GND | Exposed pad (EP). EP on the package bottom is thermally connected to the die for improved heat transfer out of the package. The pad is not electrically connected to the die, but is recommended to be soldered to GND on the PC Board. |

DEVICE CONFIGURATION

Table 2. CONTROL PIN EFFECTS (Typical Values)

| Pin | Description | Logic State | Equalization Gain |
|-----|---------------------|-------------|----------------------------|
| EQ | Equalization Amount | Low | 3 dB |
| | | Mid | 6 dB |
| | | High | 9 dB |
| Pin | Description | Logic State | De-emphasis Ratio (Note 1) |
| DE | De-Emphasis Amount | Low | 0 dB |
| | | Mid | -3.5 dB |
| | | High | –5.5 dB |

1. dB Decrease = 20 log * (VTX-DE / VTX-DIFF-PP)

Table 3. ATTRIBUTES

| Parameter | | |
|---|--|----------------------|
| ESD Protection | Human Body Model Charged Device Model | > 4 kV > 1.5 kV |
| Moisture Sensitivity, Indefinite Time Out of Drypack (Note 2) | | Level 1 |
| Flammability Rating | Oxygen Index: 28 to 34 | UL 94 V–O @ 0.125 in |
| Transistor Count | | 1828 |
| Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test | | |

2. For additional information, see Application Note AND8003/D.

Table 4. ABSOLUTE MAXIMUM RATINGS

Over operating free-air temperature range (unless otherwise noted)

| Parameter | Description | Min | Max | Unit |
|--|------------------|------|-----------------------|------|
| Supply Voltage (Note 3) | Vcc | -0.5 | 4.6 | V |
| Voltage range at any input or | Differential I/O | -0.5 | 1.89 | V |
| output terminal | LVCMOS inputs | -0.5 | V _{CC} + 0.5 | V |
| Storage Temperature Range, T _{SG} | | -65 | 150 | °C |
| Maximum Junction Temperature, T _J | | | 125 | °C |
| Operating Ambient Temperature Range, T _A | | -40 | 85 | °C |
| Junction-to-Ambient Thermal Resistance @ 500 lfm, θ_{JA} (Note 4) | | | 34 | °C/W |
| Wave Solder, Pb–Free, T _{SOL} | | | 265 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

3. All voltage values are with respect to the GND terminals.

4. JEDEC standard multilayer board - 2S2P (2 signal, 2 power).

Table 5. RECOMMENDED OPERATING CONDITIONS

Over operating free-air temperature range (unless otherwise noted)

| Parameter | Description | Min | Nom | Max | Unit |
|-----------------|--------------------------------|-------|-----|-------|------|
| V _{CC} | Main power supply | 3.135 | 3.3 | 3.465 | V |
| T _A | Operating free-air temperature | -40 | | +85 | °C |
| C _{AC} | AC coupling capacitor | 75 | 100 | 265 | nF |

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

| Table 6. POWER SUPPLY CHARACT | ERISTICS |
|-------------------------------|-----------------|
| Parameter | Test Conditions |

| | Parameter | Test Conditions | Min | Typ (Note 5) | Max | Unit |
|-----|-------------------|---|-----|-----------------|-----|------|
| | Active | Link in U0 with Super Speed Plus data transmission $DE = Iow 0 dB, EQ = Iow 3 dB$ | | 150 | | mA |
| Icc | Idle State | Link has some activity, not in U0 DE = mid -3.5 dB, EQ = mid 6dB | | 105 | | mA |
| | U2/U3 | Link in U2 or U3 power saving state DE = mid -3.5 dB, EQ = mid 6 dB | | 12.9 | | mA |
| | No USB Connection | No connection state, termination disabled $DE = mid -3.5 dB$, EQ = mid 6 dB | | 12.7 | | mA |

5. TYP values use V_{CC} = 3.3 V, T_A = 25°C.

Table 7. LVCMOS CONTROL PIN CHARACTERISTICS

| | Parameter | Test Conditions | Min | Тур | Max | Unit |
|-----------------|-------------------------------|--|-----------------------|---------------------|-----------------------|------|
| 3–State LVCM | DS Inputs (EQ, DE) | | | | | |
| VIH | High-level input voltage | | 0.8 * V _{CC} | | V _{CC} | V |
| VIM | Mid-level input voltage | | 0.4 * V _{CC} | V _{CC} / 2 | 0.6 * ^V CC | V |
| V _{IL} | Low-level input voltage | | GND | | 0.2 * ^V CC | V |
| V _F | Floating voltage | V _{IN} = High impedance | | V _{CC} / 2 | | V |
| R _{PU} | Internal pull-up resistance | | | 250 | | kΩ |
| R _{PD} | Internal pull-down resistance | | | 250 | | kΩ |
| I _{IH} | High-level input current | V _{IN} = 3.465 V | | | 20 | μΑ |
| Ι _{ΙL} | Low-level input current | V _{IN} = GND, V _{CC} = 3.465 V | -20 | | | μΑ |

Table 8. RECEIVER AC/DC CHARACTERISTICS Over operating free-air temperature range (unless otherwise noted)

| | Parameter | Test Conditions | Min | Тур | Max | Unit |
|--------------------------|---|--|-----|---------------------------|------|------------------|
| V _{RX-DIFF-pp} | Input differential voltage swing | AC-coupled, peak-to-peak | 250 | | 1200 | mV _{PP} |
| V _{RX-CM} | Common-mode voltage bias in the receiver (DC) | | | V _{CC} - 0.25 | | V |
| Z _{RX-DIFF} | Differential input impedance (DC) | Present after an USB device is detected on TX+/TX- | 80 | 100 | 120 | Ω |
| Z _{RX-CM} | Common-mode input impedance (DC) | Present after an USB device is detected on TX+/TX- | 20 | 25 | 30 | Ω |
| Z _{RX-HIGH-IMP} | Common-mode input impedance with termination disabled (DC) | Present when no USB device is detected on TX+ | 25 | 190 | | kΩ |
| V _{TH-LFPS-pp} | Low Frequency Periodic Signaling (LFPS) Detect Threshold | Output voltage is considered squelched below this threshold voltage. | | | 300 | mV _{PP} |

| | Parameter | Test Conditions | Min | Тур | Max | Unit |
|---|---|--|-----|----------------------|-----------------|------------------|
| V _{TX-DIFF-PP} | Output differential voltage swing | 50 Ω to V _{CC} , DE = Low 0 dB, EQ = Low 3 dB | | 1000 | | mV _{PP} |
| C _{TX} | TX input capacitance to GND | At 2.5 GHz | | 1.25 | | pF |
| $Z_{TX-DIFF}$ | Differential output impedance (DC) | Present after an USB device is detected on TX+/TX- | 80 | 100 | 120 | Ω |
| Z _{TX-CM} | Common–mode output impedance (DC) | Present after an USB device is detected on TX+/TX- | 20 | | 30 | Ω |
| I _{TX-SC} | TX short circuit current | TX+ or TX- shorted to GND | | 60 | | mA |
| V _{TX-CM} | Common–mode voltage bias in the transmitter (DC) | | | V _{CC} -0.6 | V _{CC} | V |
| V _{TX-CM-ACpp} | AC common-mode peak-to-peak volt- age swing in active mode | Within U0 and within LFPS | | | 100 | mV _{PP} |
| /TX-IDLE-DIFF-ACpp | Differential voltage swing during electrical idle | Tested with a high-pass filter | 0 | | 10 | mV _{PF} |
| V _{TX-RXDET} | Voltage change to allow receiver detect | Positive voltage to sense receiver termination | | | 600 | mV |
| t _R , t _F | Output rise, fall time | 20% – 80% of differential voltage measured 1 inch from the output pin | | 45 | | ps |
| t _{RF-MM} | Output rise, Fall time mismatch | 20% – 80% of differential voltage measured 1 inch from the output pin | | | 5 | ps |
| $t_{diff-LH}, t_{diff-HL}$ | Differential propagation delay | De-emphasis = -3.5 dB, propagation delay between 50% level at input and output | | 150 | | ps |
| t _{idleEntry} , t _{idleExit} | Idle entry and exit times | | | 30 | | ns |

Table 9. TRANSMITTER AC/DC CHARACTERISTICS Over operating free-air temperature range (unless otherwise noted)

Table 10. TIMING AND JITTER CHARACTERISTICS

| | Parameter | Test Conditions | Min | Тур | Max | Unit |
|--------------------|---|---|-----|-----|-----|------|
| TIMING | | | | | | |
| t _{READY} | Time from power applied until RX termination is enabled | Apply 0 V to V_{CC} , connect USB termination to TX±, apply 3.3 V to V_{CC} , and measure when $Z_{RX-DIFF}$ is enabled | | 10 | | ms |

JITTER FOR 5 Gbps

| T _{JTX-EYE} | Total jitter (Notes 6, 7) | EQ = Low 3 dB, DE = Low 0 dB | 0.038 | UI (Note 8) |
|----------------------|-------------------------------|------------------------------|-------|----------------|
| D _{JTX} | Deterministic jitter (Note 7) | | 0.018 | UI (Note 8) |
| R _{JTX} | Random jitter (Note 7) | | 0.003 | UI (Note 8) |

JITTER FOR 10 Gbps

| T _{JTX-EYE} | Total jitter (Notes 6, 7) | EQ = Low 3 dB, DE = Low 0 dB | 0.084 | UI (Note 8) |
|----------------------|-------------------------------|------------------------------|-------|----------------|
| D _{JTX} | Deterministic jitter (Note 7) | | 0.047 | UI (Note 8) |
| R _{JTX} | Random jitter (Note 7) | | 0.006 | UI (Note 8) |

6. Includes RJ at 10⁻¹².

Modele it is at the ends of reference channel with a K28.5 pattern, VID = 1000 mVpp, -3.5 dB de-emphasis from source.
5 Gbps, UI = 200 ps for 10 Gbps, UI = 100 ps

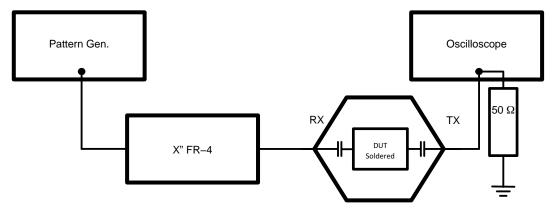


Figure 3. Equalization Measurement Setup

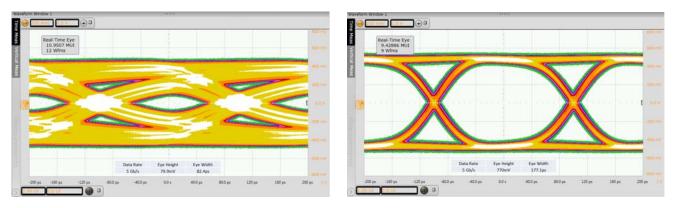


Figure 4. 5 Gbps Signal with 24 inches of FR4 Before Input to NB7NPQ702M and After Using High EQ Setting

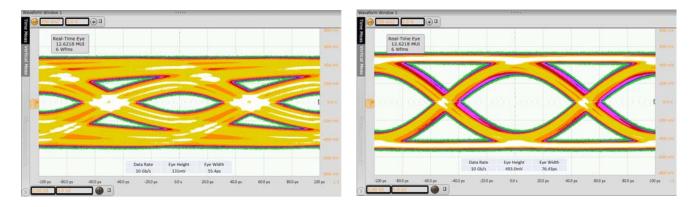


Figure 5. 10 Gbps Signal with 12 inches of FR4 Before Input to NB7NPQ702M and After with EQ Floating (Mid)

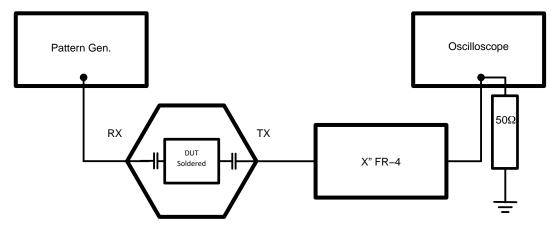


Figure 6. De-Emphasis Measurement Setup

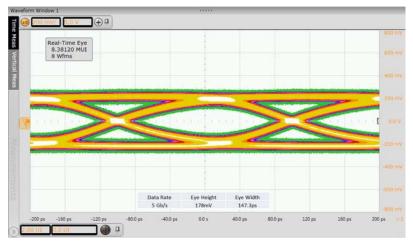


Figure 7. 5 Gbps Signal After 24 inches of FR4 at Output with High DE Setting to NB7NPQ702M

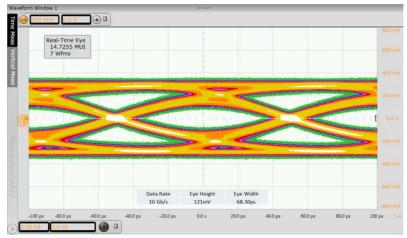
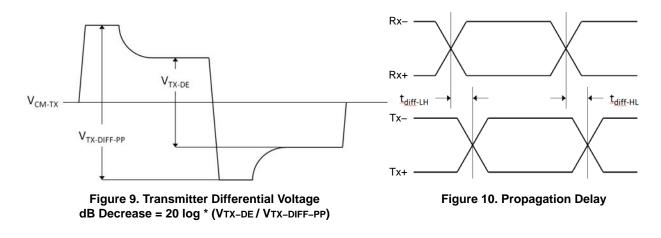


Figure 8. 10 Gbps Signal After 9 inches of FR4 at Output with Mid DE Setting to NB7NPQ702M

PARAMETER MEASUREMENT DIAGRAMS



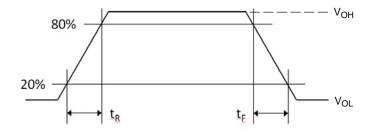


Figure 11. Output Rise and Fall Times

APPLICATION GUIDELINES

LFPS Compliance Testing

As part of USB 3.1 compliance test, the host or peripheral must transmit a LFPS signal that adheres to the spec parameters. When using a real-time oscilloscope to capture this data, *the scope's trigger must be below 0 V when making single-ended measurements*. Although the differential signal is identical to that which is expected by the USB 3.1 system, the AC common mode voltage for LFPS may fall below 0 V during short bursts of switching signal, which is still within the spec's limit.

LFPS Functionality

USB 3.1 links use Low Frequency Periodic Signaling (LFPS) to implement functions like exiting low-power modes, performing warm resets and providing link training

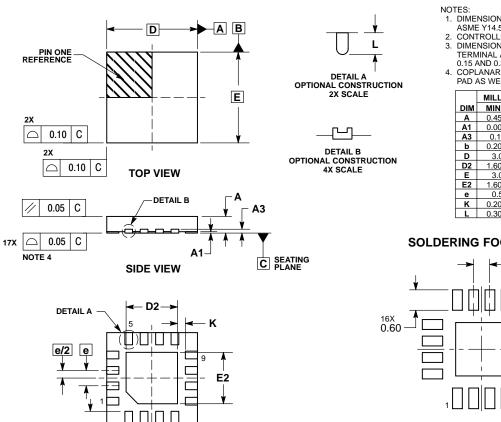
between host and peripheral devices. LFPS signaling consists of bursts of frequencies ranging between 10 to 50 MHz and can have specific burst lengths or repeat rates.

Ping.LFPS for TX Compliance

During the transmitter compliance, the system under test must transmit certain compliance patterns as defined by the USB–IF. In order to toggle through these patterns for various tests, the receiver must receive a ping. LFPS signal from either the test suite or a separate pattern generator. The standard signal comprises of a single burst period of 100ns at 20 MHz. In order to pass this signal through NB7NPQ702M, *the duration of the burst must be extended to at least 200 ns.*

PACKAGE DIMENSIONS

UQFN16 3x3, 0.5P CASE 523AF ISSUE B



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BOTTOM VIEW

16X b

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0.10

CAB

NOTE 3

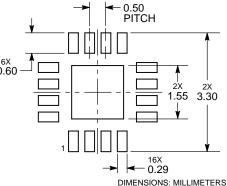
С 0.05

DIMENSIONING AND TOLERANCING PER

- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 MM FROM TERMINAL TIP. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

| | MILLIMETERS | | | |
|-----|-------------|------|--|--|
| DIM | MIN | MAX | | |
| Α | 0.45 | 0.55 | | |
| A1 | 0.00 | 0.05 | | |
| A3 | 0.127 REF | | | |
| b | 0.20 | 0.30 | | |
| D | 3.00 BSC | | | |
| D2 | 1.60 | 1.80 | | |
| Е | 3.00 BSC | | | |
| E2 | 1.60 | 1.80 | | |
| е | 0.50 BSC | | | |
| К | 0.20 | | | |
| L | 0.30 | 0.50 | | |

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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